



Search Notes 	Application/Control No.	Applicant(s)/Patent Under Reexamination
	09349638	SHOFF ET AL.
	Examiner Huynh, Son P	Art Unit 2623


Notes	Date	Examiner
Chris Kelley (725 - Appeal Conference)	7/7/06	AH
Vivek Srivastava (Appeal Conference)	7/7/06	AH

U.S. Patent and Trademark Office	Part of Paper No.: 20060707
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<i>Interference Searched</i> 	Application/Control No. 09349638	Applicant(s)/Patent Under Reexamination SHOFF ET AL.
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Class	SubClass	Date	Examiner
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